

INTERNATIONAL STANDARD

Measurement techniques of piezoelectric, dielectric and electrostatic
oscillators –
Part 3: Frequency aging test methods

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

**MEASUREMENT TECHNIQUES OF PIEZOELECTRIC,
DIELECTRIC AND ELECTROSTATIC OSCILLATORS –****Part 3: Frequency aging test methods**

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International Standard IEC 62884-3 has been prepared by IEC technical committee 49: Piezoelectric, dielectric and electrostatic devices and associated materials for frequency control, selection and detection.

The text of this International Standard is based on the following documents:

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49/1248/CDV	49/1272/RVC

Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

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